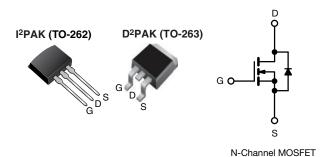


Vishay Siliconix

HALOGEN

# **Power MOSFET**



PRODUCT SUMMARY					
V <sub>DS</sub> (V)	600	600			
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	V <sub>GS</sub> = 10 V 2.2			
Q <sub>g</sub> max. (nC)	31	31			
Q <sub>gs</sub> (nC)	4.6	4.6			
Q <sub>gd</sub> (nC)	17	17			
Configuration	Sing	Single			

#### **FEATURES**

- Surface-mount (IRFBC30S, SiHFBC30S)
- Low-profile through-hole (IRFBC30L, SiHFBC30L)
- Available in tape and reel (IRFBC30S, SiHFBC30S)
- Dynamic dV/dt rating
- 150 °C operating temperature
- Fast switching
- Fully avalanche rated
- Material categorization: for definitions of compliance please see <a href="https://www.vishav.com/doc?99912"><u>www.vishav.com/doc?99912</u></a>

#### Note

\* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

#### **DESCRIPTION**

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The D²PAK is a surface-mount power package capable of the accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface-mount package. The D²PAK is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface-mount application. The through-hole version (IRFBC30L, SiHFBC30L) is a available for low-profile applications.

ORDERING INFORMATION			
Package	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	I <sup>2</sup> PAK (TO-262)
Lead (Pb)-free and halogen-free	SiHFBC30S-GE3	SiHFBC30STRL-GE3 a	SiHFBC30L-GE3
Lead (Pb)-free	IRFBC30SPbF	IRFBC30STRLPbF a	-

#### Note

a. See device orientation

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-source voltage		$V_{DS}$	600	V		
Gate-source voltage		$V_{GS}$	± 20	7 v		
Continuous drain current e	$V_{GS}$ at 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$	I_	3.6			
Continuous drain current	$V_{GS}$ at 10 $V_{CS}$ $T_{C} = 100 ^{\circ}C$	I <sub>D</sub>	2.3	Α		
Pulsed drain current a, e	$I_{DM}$	14				
Linear derating factor			0.59	W/°C		
Single pulse avalanche energy b, e		E <sub>AS</sub>	290	mJ		
Avalanche current <sup>a</sup>		I <sub>AR</sub>	3.6	Α		
Repetitive avalanche energy <sup>a</sup>		E <sub>AR</sub>	7.4	mJ		
Maximum naver dissination	T <sub>A</sub> = 25 °C	ם	3.1	w		
Maximum power dissipation	T <sub>C</sub> = 25 °C	$P_{D}$	74	7 ~~		
Peak diode recovery dV/dt c, e	dV/dt	3.0	V/ns			
Operating junction and storage temperature range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C			
Soldering recommendations (peak temperature) d	for 10 s		300	7		

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 \,^{\circ}\text{C}$ ,  $L = 41 \,\text{mH}$ ,  $R_g = 25 \,^{\circ}\Omega$ ,  $I_{AS} = 3.6 \,\text{A}$  (see fig. 12)
- c.  $I_{SD} \le 3.6$  A,  $dI/dt \le 60$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C
- d. 1.6 mm from case
- e. Uses IRFBC30, SiHFBC30 data and test conditions



# IRFBC30S, SiHFBC30S, IRFBC30L, SiHFBC30L

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THERMAL RESISTANCE RATINGS					
PARAMETER SYMBOL TYP. MAX. UNIT					
Maximum junction-to-ambient (PCB mounted, steady-state) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W	
Maximum junction-to-case (drain)	R <sub>thJC</sub>	-	1.7		

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material). For recommended footprint and soldering techniques refer to application note #AN-994

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-source breakdown voltage	V <sub>DS</sub>	V <sub>GS</sub>	= 0, I <sub>D</sub> = 250 μA	600	-	-	V
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I <sub>D</sub> = 1 mA °	-	0.62	-	V/°C
Gate-source threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-source leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zero gate voltage drain current	I <sub>DSS</sub>		= 600 V, V <sub>GS</sub> = 0 V	-	-	100	μA
			/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	500	
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V		-	-	2.2	Ω
Forward transconductance	9fs	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> = 2.2 A <sup>c</sup>	2.5	-	-	S
Dynamic		<u> </u>			1	1	
Input capacitance	C <sub>iss</sub>	$V_{GS} = 0 V$ ,		-	660	-	_
Output capacitance	C <sub>oss</sub>		V <sub>DS</sub> = 25 V, 0 MHz, see fig. 5 <sup>c</sup>	-	86	-	pF
Reverse transfer capacitance	$C_{rss}$	1 = 1.	U MITZ, See lig. 5	ı	19	-	
Total gate charge	$Q_g$			-	-	31	nC
Gate-source charge	$Q_{gs}$	$V_{GS} = 10 \text{ V}$	V <sub>GS</sub> = 10 V		-	4.6	
Gate-drain charge	$Q_{gd}$			ı	-	17	
Turn-on delay time	t <sub>d(on)</sub>			ı	11	-	
Rise time	t <sub>r</sub>	$V_{DD}$ = 300 V, $I_{D}$ = 3.6 A, $R_{g}$ = 12 $\Omega$ , $R_{D}$ = 82 $\Omega$ , see fig. 10 $^{b, c}$		1	13	-	ns
Turn-off delay time	$t_{d(off)}$			-	35	-	
Fall time	t <sub>f</sub>			-	14	-	
Gate input resistance	R <sub>g</sub>	f = 1	MHz, open drain	0.5	-	4.9	Ω
Internal source inductance	L <sub>S</sub>	Between lead	, and center of die contact	-	7.5	-	nH
<b>Drain-Source Body Diode Characteristic</b>	cs						
Continuous source-drain diode current	I <sub>S</sub>	MOSFET s showing	,	-	-	3.6	
Pulsed diode forward current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	14	A
Body diode voltage	$V_{SD}$	T <sub>J</sub> = 25 °C	$I_{S} = 3.6 \text{ A}, V_{GS} = 0 \text{ V}^{\text{ b}}$	-	-	1.6	V
Body diode reverse recovery time	t <sub>rr</sub>	T 05 00 1	0.0.4 -11/-14 - 400.47 - 5.0	ı	370	810	ns
Body diode reverse recovery charge	Q <sub>rr</sub>	$T_{\rm J} = 25~{\rm ^{\circ}C}, I_{\rm F} = 3.6~{\rm A},  {\rm dI/dt} = 100~{\rm A/\mu s}^{\rm b,c}$		-	2.0	4.2	μC
Forward turn-on time	t <sub>on</sub>	Intrinsic tu	ırn-on time is negligible (turn	on is dor	ninated b	y L <sub>S</sub> and	L <sub>D</sub> )

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %
- c. Uses IRFBC30, SiHFBC30 data and test conditions

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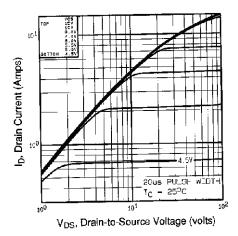


Fig. 1 - Typical Output Characteristics

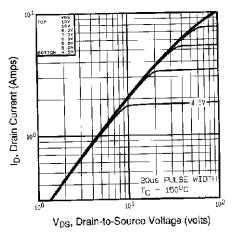


Fig. 2 - Typical Output Characteristics

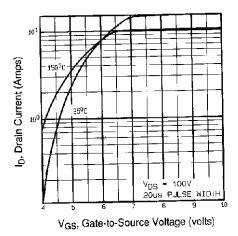


Fig. 3 - Typical Transfer Characteristics

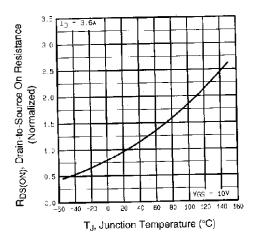


Fig. 4 - Normalized On-Resistance vs. Temperature

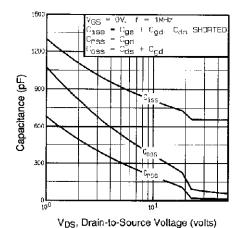


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

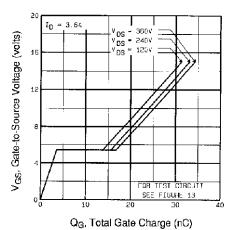


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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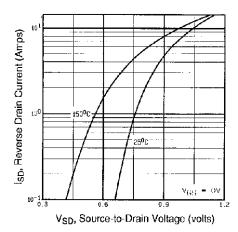


Fig. 7 - Typical Source-Drain Diode Forward Voltage

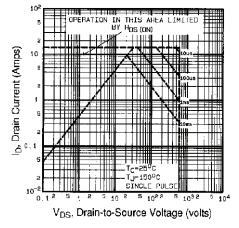


Fig. 8 - Maximum Safe Operating Area

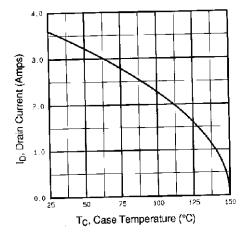


Fig. 9 - Maximum Drain Current vs. Case Temperature

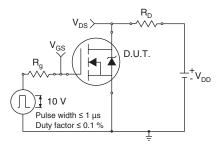


Fig. 10a - Switching Time Test Circuit

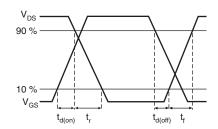


Fig. 10b - Switching Time Waveforms

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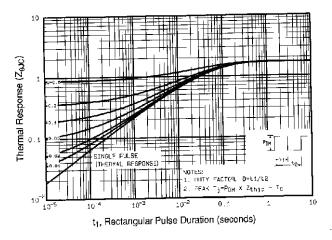


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

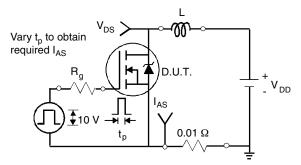


Fig. 12a - Unclamped Inductive Test Circuit

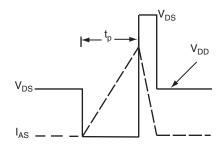


Fig. 12b - Unclamped Inductive Waveforms

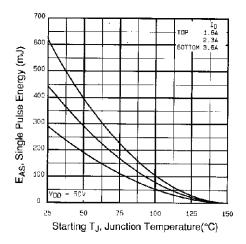


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

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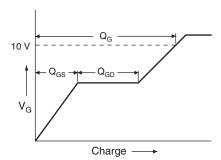


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

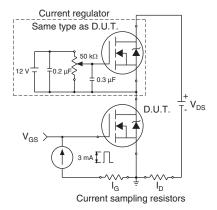
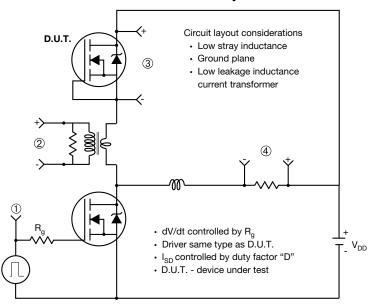


Fig. 13b - Gate Charge Test Circuit

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### Peak Diode Recovery dV/dt Test Circuit



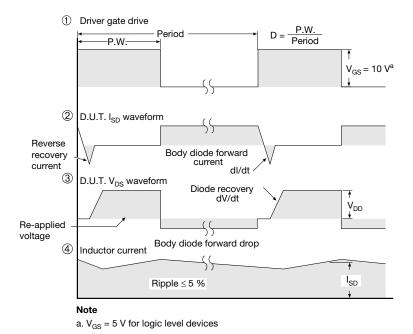


Fig. 14 - For N-Channel

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## **TO-263AB (HIGH VOLTAGE)**







	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
Е	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	ı
е	2.54 BSC		0.100 BSC	
Н	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	ı	0.066
L2	-	1.78	-	0.070
L3	0.25	BSC	0.010 BSC	
L4	4.78	5.28	0.188	0.208

ECN: S-82110-Rev. A, 15-Sep-08

DWG: 5970

#### Notes

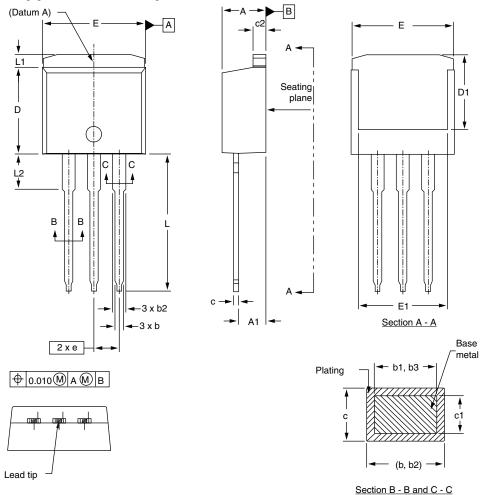
- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

Document Number: 91364 www.vishay.com Revision: 15-Sep-08





# I<sup>2</sup>PAK (TO-262) (HIGH VOLTAGE)



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	2.03	3.02	0.080	0.119
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D	8.38	9.65	0.330	0.380
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54 BSC		0.100 BSC	
L	13.46	14.10	0.530	0.555
L1	-	1.65	-	0.065
L2	3.56	3.71	0.140	0.146

Scale: None

ECN: S-82442-Rev. A, 27-Oct-08 DWG: 5977

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.
- 3. Thermal pad contour optional within dimension E, L1, D1, and E1.
- 4. Dimension b1 and c1 apply to base metal only.

Document Number: 91367 Revision: 27-Oct-08





# RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)

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